## Notice of References Cited Application/Control No. 10/525,586 Applicant(s)/Patent Under Reexamination THORNER, JAN BENGT Examiner MARTIN LERNER 2626 Applicant(s)/Patent Under Reexamination THORNER, JAN BENGT Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2003/0088697	05-2003	Matsuhira, Naoki	709/238
*	В	US-6,463,443	10-2002	Thorner et al.	707/104.1
*	C	US-5,764,735	06-1998	Thorner, Jan	379/93.07
*	D	US-6,693,878	02-2004	Daruwalla et al.	370/235
*	Е	US-6,751,308	06-2004	Sahala, Kai	379/225
*	F	US-6,879,680	04-2005	Donovan et al.	379/220.01
*	G	US-7,085,827	08-2006	Ishizaki et al.	709/223
*	Η	US-2004/0158705	08-2004	Burdett et al.	713/151
*	I	US-6,363,150	03-2002	Bhagavath et al.	380/225
	J	US-			
	K	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Ø					
	R					
	Ø					
	Т					

## **NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	х	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.